

Notice of References Cited

Application/Control No.

10/539,927

Applicant(s)/Patent Under
Reexamination
MITRA ET AL.

Examiner

Ross N. Gushi

Art Unit

2833

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,599,151	07-2003	Chiran et al.	439/610
*	B	US-4,653,836	03-1987	Peele, Wayne L.	439/610
*	C	US-5,755,597	05-1998	Panis et al.	439/610
*	D	US-2001/0055909	12-2001	Van Zanten, Albertus	439/610
*	E	US-5,831,815	11-1998	Miller et al.	361/679
*	F	US-2006/0105632	05-2006	Szczesny et al.	439/610
*	G	US-6,328,601	12-2001	Yip et al.	439/608
*	H	US-6,386,919	05-2002	Medina et al.	439/610
*	I	US-2007/0037450	02-2007	Wu, Jerry	439/610
*	J	US-6,036,543	03-2000	Panis et al.	439/607
*	K	US-6,203,377	03-2001	Grek et al.	439/610
*	L	US-6,270,382	08-2001	Droesbeke et al.	439/701
*	M	US-6,629,858	10-2003	Lo et al.	439/607

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	T					

NON-PATENT DOCUMENTS

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	U	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,224,423	05-2001	Yip et al.	439/608
*	B	US-5,409,400	04-1995	Davis, Wayne S.	439/610
*	C	US-5,372,513	12-1994	Rodrigues et al.	439/98
*	D	US-6,146,205	11-2000	Lai, Chin-Te	439/610
*	E	US-6,231,392	05-2001	van Woensel, Johannes Maria Blasius	439/610
*	F	US-6,428,359	08-2002	Van Zanten, Albertus	439/610
*	G	US-6,007,384	12-1999	Kraemer et al.	439/610
*	H	US-5,167,523	12-1992	Crimmins et al.	439/350
*	I	US-5,387,130	02-1995	Fedder et al.	439/610
*	J	US-2002/0025722	02-2002	Inagawa et al.	439/610
*	K	US-6,017,245	01-2000	Karir, Arvind	439/610
*	L	US-5,244,415	09-1993	Marsilio et al.	439/610
*	M	US-5,195,909	03-1993	Huss et al.	439/465

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,960,392	10-1990	Dickie, Robert G.	439/620.05
*	B	US-6,019,627	02-2000	Embo et al.	439/412
*	C	US-2002/0146926	10-2002	Fogg et al.	439/362
*	D	US-2007/0037437	02-2007	Wu, Jerry	439/449
*	E	US-6,705,894	03-2004	Comerci et al.	439/607
*	F	US-6,887,091	05-2005	Wu, Jerry	439/352
*	G	US-6,582,255	06-2003	Simmons et al.	439/701
*	H	US-6,582,244	06-2003	Fogg et al.	439/362
*	I	US-6,217,364	04-2001	Miskin et al.	439/358
*	J	US-5,564,940	10-1996	Rodriques et al.	439/404
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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